

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination ANDOH, TSUYOSHI	
		Examiner Andrew L. Snizek	Art Unit 2627	Page 1 of 1

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-6,625,627	09-2003	Haneda, Naoya	707/205
B	US-			
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D	US-			
E	US-			
F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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